

<b>Notice of References Cited</b>	Application/Control No. 10/771,691	Applicant(s)/Patent Under Reexamination LIN, WEN CHIN ET AL.	
	Examiner Andrew Q. Tran	Art Unit 2824	Page 1 of 1

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	K	US-			
	L	US-			
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**NON-PATENT DOCUMENTS**

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